

AON2240

40V N-Channel MOSFET

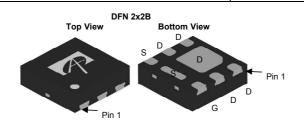
General Description

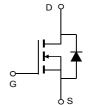
The AON2240 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

Product Summary

 $\begin{array}{lll} V_{DS} & 40V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 8A \\ R_{DS(ON)} \; (at \; V_{GS} \; = \! 10V) & < 21 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \; = \! 4.5V) & < 29 m\Omega \end{array}$







Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	40	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain T _A =25°C			8	
Current G	T _A =100°C	'D	6	A
Pulsed Drain Current ^c		I _{DM}	32	
	T _A =25°C	р	2.8	w
Power Dissipation ^A T _A =70°C		P _D	1.8	VV
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

Thermal Characteristics							
Parameter	Symbol Typ Max			Units			
Maximum Junction-to-Ambient A	t ≤ 10s	D	37	45	°C/W		
Maximum Junction-to-Ambient AD	Steady-State	$\kappa_{\theta JA}$	66	80	°C/W		



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC I	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		40			V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =40V, V_{GS} =0V				1	μА
			T _J =55°C			5	μΑ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V	V _{DS} =0V, V _{GS} =±20V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	$V_{DS}=V_{GS}$, $I_D=250\mu A$			2.4	V
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V		32			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =8A			16.8	21	mΩ
			T _J =125°C		24.5	31	11152
		V_{GS} =4.5V, I_D =4A			22.6	29	mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =8A			33		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.75	1	V
Is	Maximum Body-Diode Continuous Cui	rent			3.5	Α	
DYNAMIC	CPARAMETERS						
C _{iss}	Input Capacitance				415		pF
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =20V, f=	V _{GS} =0V, V _{DS} =20V, f=1MHz		112		pF
C _{rss}	Reverse Transfer Capacitance				11		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1	2.2	3.5	Ω
SWITCH	NG PARAMETERS						
Q _g (10V)	Total Gate Charge		V _{GS} =10V, V _{DS} =20V, I _D =8A		6.5	12	nC
Q _g (4.5V)	Total Gate Charge	\/_ =10\/_\/_ =20\/_			3	6	nC
Q_{gs}	Gate Source Charge	V _{GS} -10V, V _{DS} -20V, I _D -6A			1.2		nC
Q_{gd}	Gate Drain Charge	7	1		1.1		nC
t _{D(on)}	Turn-On DelayTime				4		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =20V, R_L =2.5 Ω , R_{GEN} =3 Ω			3		ns
t _{D(off)}	Turn-Off DelayTime				15		ns
t _f	Turn-Off Fall Time				2		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =8A, dI/dt=100A/μs			12.5		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =8A, dI/dt=100A/μs			3.5		nC

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_{A} =25° C. The Power dissipation P_{DSM} is based on R_{BJA} t \leq 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

- D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

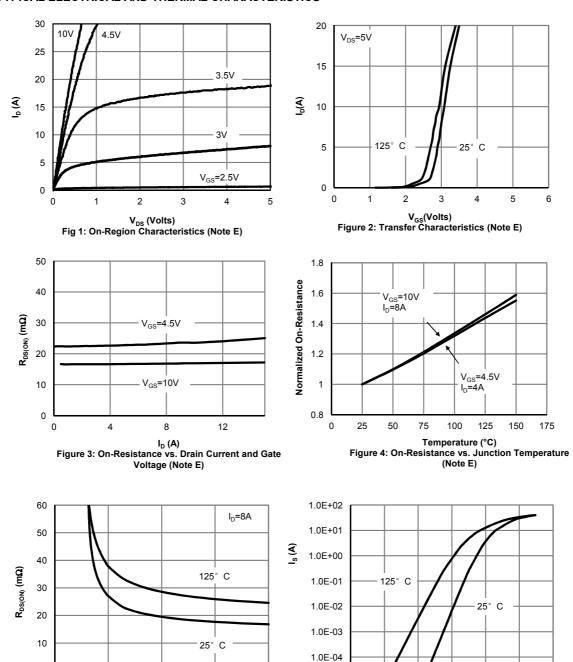


0 2

6

V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



10

1.0E-05

0.0

 $V_{\rm SD}$ (Volts) 0.2 0.4 0.6 0.8 1.0 1 $V_{\rm SD}$ (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

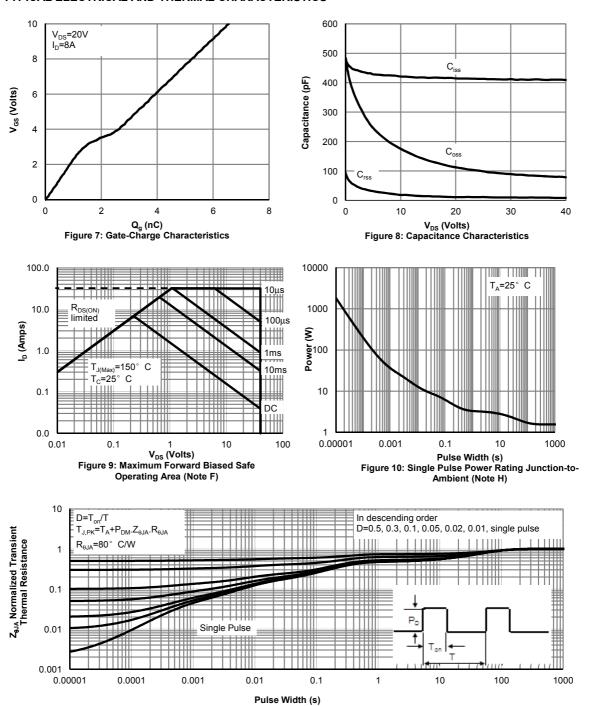
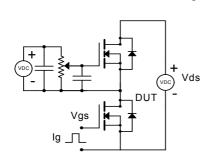
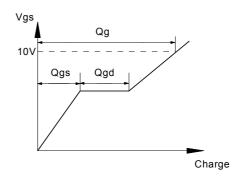


Figure 11: Normalized Maximum Transient Thermal Impedance (Note H)

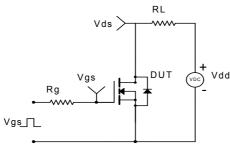


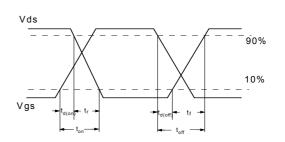
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

